



## Description

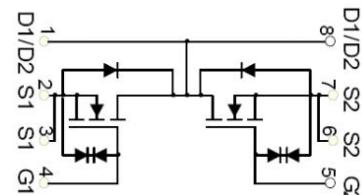
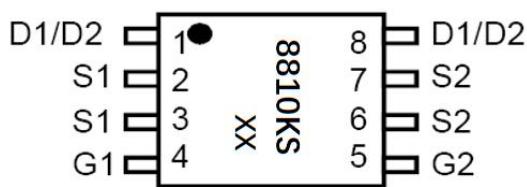
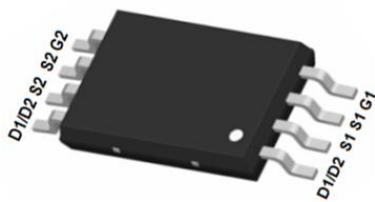
### JMT N-channel Enhancement Mode Power MOSFET

#### Features

- 20V, 4.8A
- $R_{DS(ON)} < 22m\Omega$  @  $V_{GS} = 4.5V$
- $R_{DS(ON)} < 35m\Omega$  @  $V_{GS} = 2.5V$
- Advanced Trench Technology
- Excellent  $R_{DS(ON)}$  and Low Gate Charge
- Lead free product is acquired
- ESD Rating: HBM 2KV

#### Application

- Load Switch
- PWM Application
- Power management



TSSOP-8 top view

Marking and pin Assignment

Schematic Diagram

## Package Marking and Ordering Information

Device Marking	Device	OUTLINE	Device Package	Reel Size	Reel (PCS)	Per Carton (PCS)
8810KS	JMTT8810KS	TAPING	TSSOP-8	13inch	5000	60000

## Absolute Maximum Ratings ( $T_A = 25^\circ C$ unless otherwise specified)

Symbol	Parameter		Max.	Units
$V_{DSS}$	Drain-Source Voltage		20	V
$V_{GSS}$	Gate-Source Voltage		$\pm 10$	V
$I_D$	Continuous Drain Current		$T_A = 25^\circ C$	A
			$T_A = 100^\circ C$	A
$I_{DM}$	Pulsed Drain Current <sup>note1</sup>		19	A
$P_D$	Power Dissipation	$T_A = 25^\circ C$	0.83	W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient		151	$^\circ C/W$
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to +150	$^\circ C$

**Electrical Characteristics** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

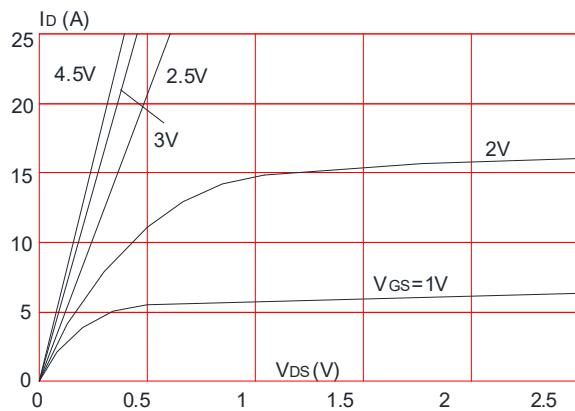
Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
<b>Off Characteristic</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_D=250\mu\text{A}$	20	-	-	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=20\text{V}$ , $V_{\text{GS}}=0\text{V}$ ,	-	-	1	$\mu\text{A}$
$I_{\text{GSS}}$	Gate to Body Leakage Current	$V_{\text{DS}}=0\text{V}$ , $V_{\text{GS}}= \pm 10\text{V}$	-	-	$\pm 10$	$\mu\text{A}$
<b>On Characteristics</b>						
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$ , $I_D=250\mu\text{A}$	0.4	0.7	1	V
$R_{\text{DS}(\text{on})}$ note2	Static Drain-Source on-Resistance	$V_{\text{GS}}=4.5\text{V}$ , $I_D=4\text{A}$	-	17	22	$\text{m}\Omega$
		$V_{\text{GS}}=2.5\text{V}$ , $I_D=3\text{A}$	-	25	35	
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=10\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1.0\text{MHz}$	-	545	-	pF
$C_{\text{oss}}$	Output Capacitance		-	103	-	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		-	90	-	pF
$Q_g$	Total Gate Charge	$V_{\text{DS}}=10\text{V}$ , $I_D=4.8\text{A}$ , $V_{\text{GS}}=4.5\text{V}$	-	8	-	nC
$Q_{\text{gs}}$	Gate-Source Charge		-	2.5	-	nC
$Q_{\text{gd}}$	Gate-Drain("Miller") Charge		-	3	-	nC
<b>Switching Characteristics</b>						
$t_{\text{d}(\text{on})}$	Turn-on Delay Time	$V_{\text{DS}}=10\text{V}$ , $R_L=1.5\Omega$ , $R_{\text{GEN}}=3\Omega$ , $V_{\text{GS}}=5\text{V}$	-	0.5	-	ns
$t_r$	Turn-on Rise Time		-	1	-	ns
$t_{\text{d}(\text{off})}$	Turn-off Delay Time		-	12	-	ns
$t_f$	Turn-off Fall Time		-	4	-	ns
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain to Source Diode Forward Current	-	-	4.8	A	
$I_{\text{SM}}$	Maximum Pulsed Drain to Source Diode Forward Current	-	-	19	A	
$V_{\text{SD}}$	Drain to Source Diode Forward Voltage	$V_{\text{GS}}=0\text{V}$ , $I_S=4.8\text{A}$	-	-	1.2	V

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

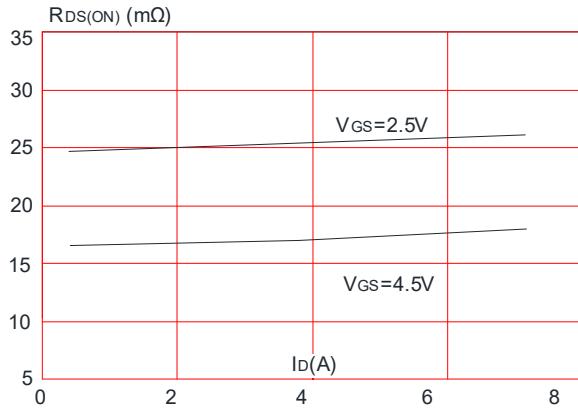
2. Pulse Test: Pulse Width $\leq 300\mu\text{s}$ , Duty Cycle $\leq 0.5\%$

## Typical Performance Characteristics

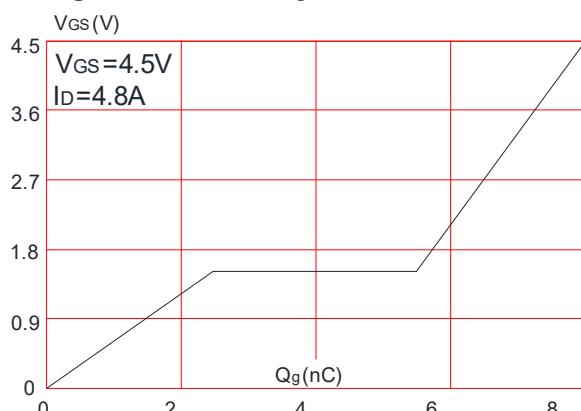
**Figure 1:** Output Characteristics



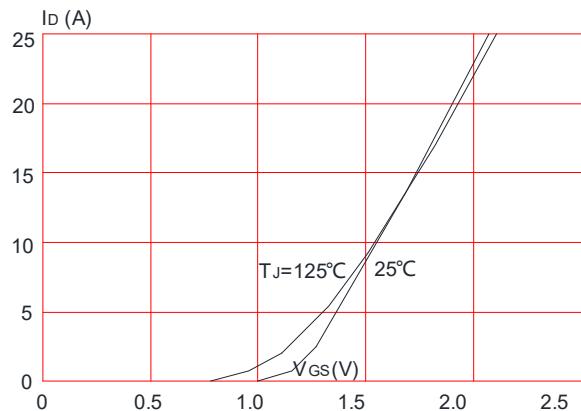
**Figure 3:** On-resistance vs. Drain Current



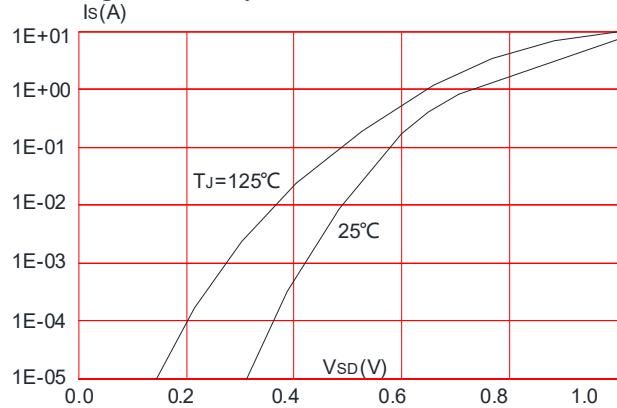
**Figure 5: Gate Charge Characteristics**



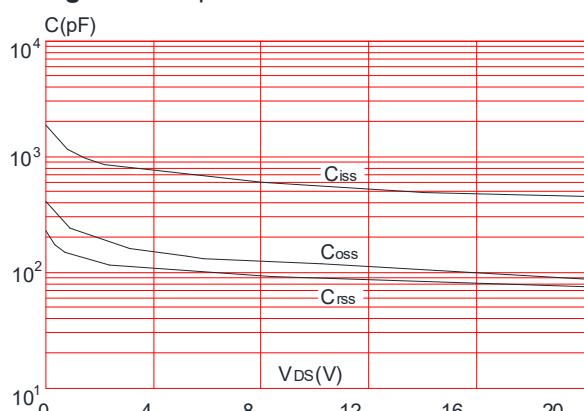
**Figure 2:** Typical Transfer Characteristics



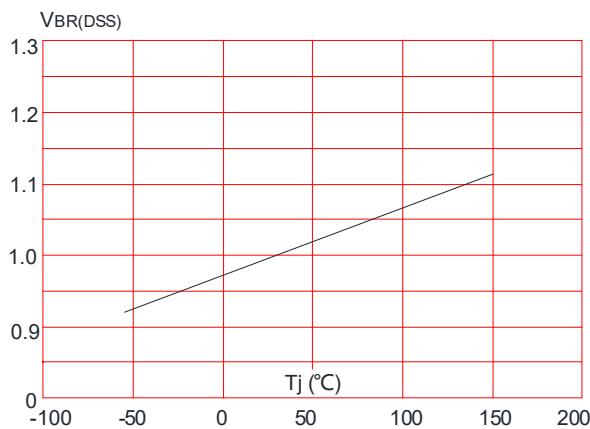
**Figure 4:** Body Diode Characteristics



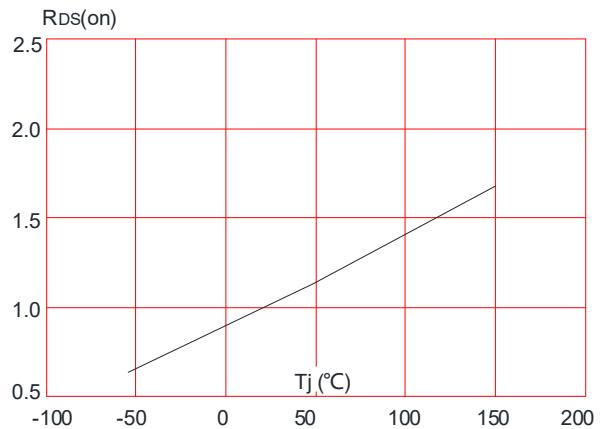
**Figure 6: Capacitance Characteristics**



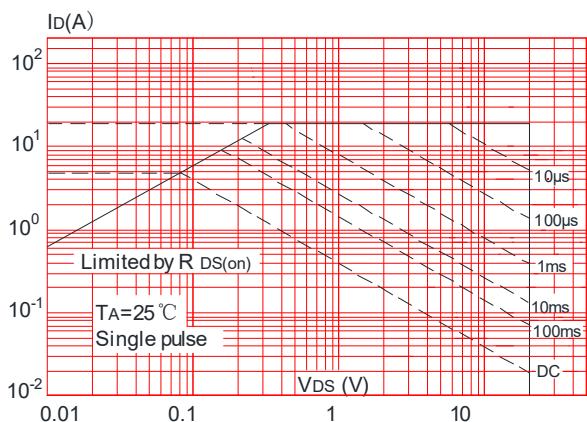
**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature



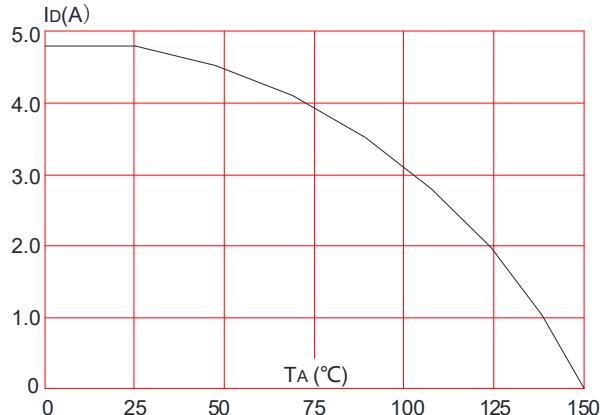
**Figure 8:** Normalized on Resistance vs. Junction Temperature



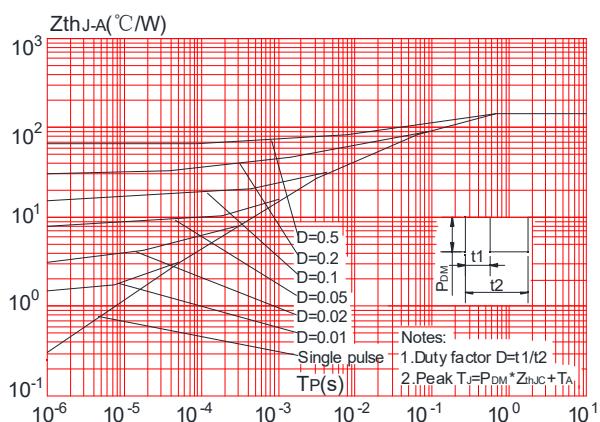
**Figure 9:** Maximum Safe Operating Area



**Figure 10:** Maximum Continuous Drain Current vs. Ambient Temperature



**Figure 11:** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



## Test Circuit

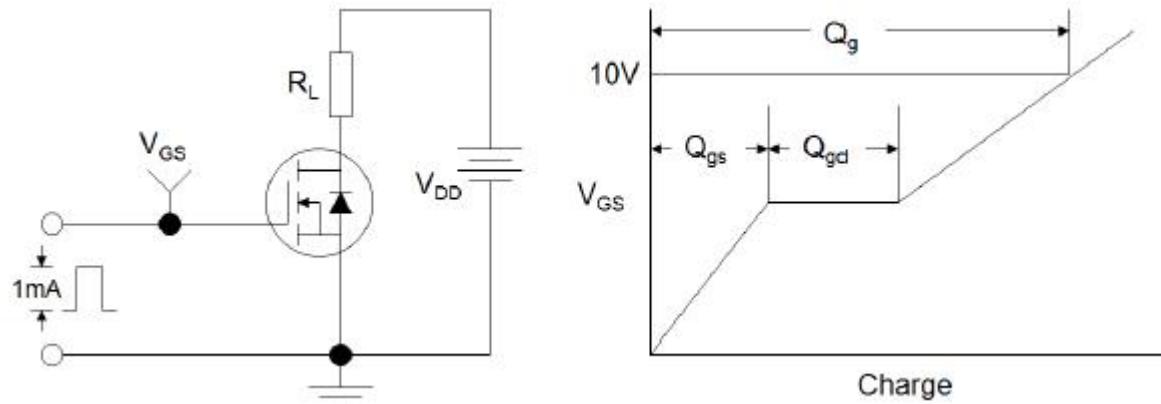


Figure1:Gate Charge Test Circuit & Waveform

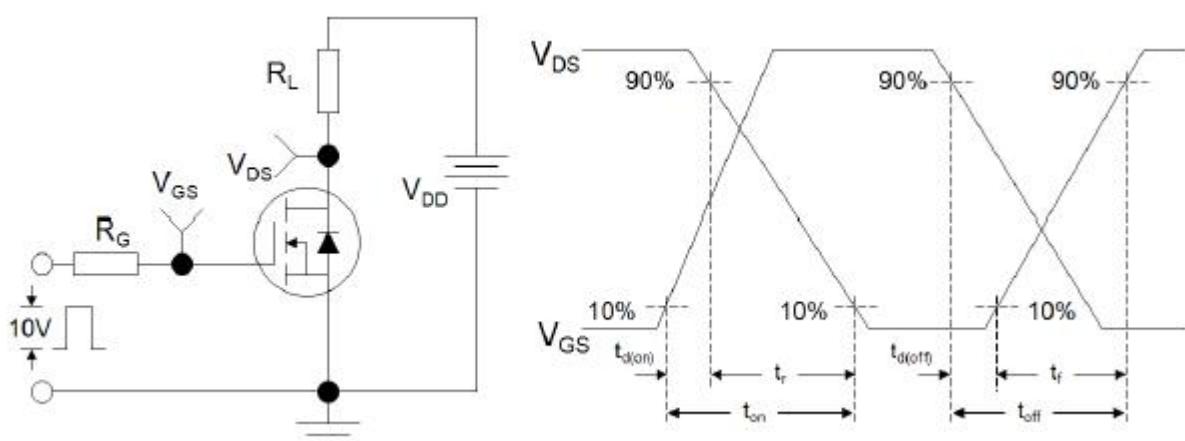


Figure 2: Resistive Switching Test Circuit & Waveforms

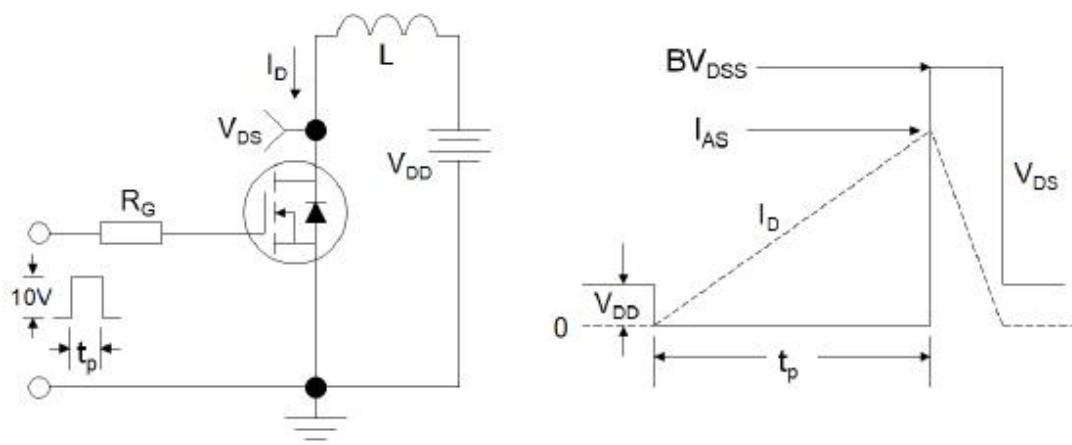
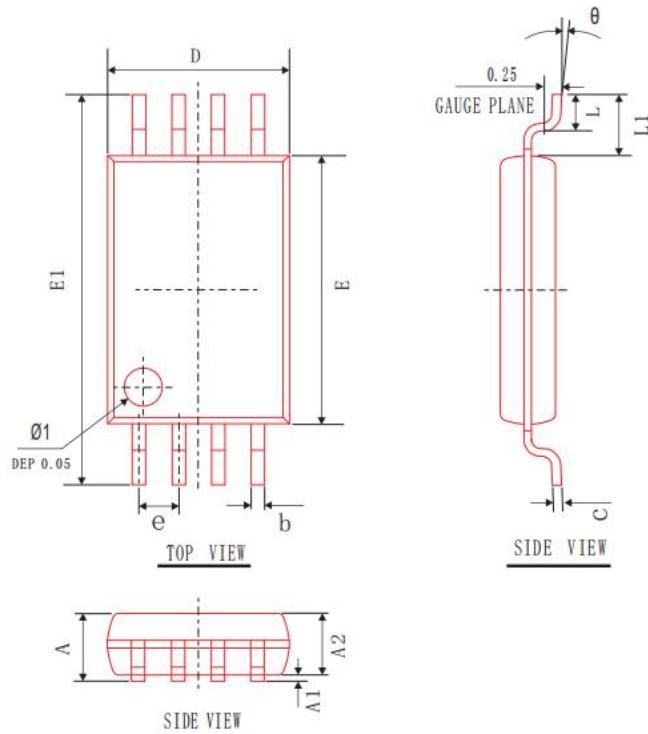


Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms



## Package Mechanical Data-TSSOP-8

COMMON DIMENSIONS  
(UNITS OF MEASURE=mm)

SYMBOL	MIN	NOM	MAX
A	1.00	1.10	1.20
A1	0.02	0.10	0.18
A2	0.90	1.00	1.10
b	0.17	0.22	0.27
c	0.122	0.127	0.132
L	0.40	0.60	0.80
D	2.87	2.97	3.07
E	4.30	4.40	4.50
E1	6.20	6.40	6.60
Ø1	0.50	0.60	0.70
θ	0°	5°	10°
L1		1.00 BSC	
e		0.65 BSC	

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